



IKEA of Sweden AB TEST REPORT

SCOPE OF WORK: FCC Part 15 subpart B – EMC report

Model: LED2208R1

REPORT NUMBER 220602638SHA-001

ISSUE DATE August 22,2022

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Report no. 220602638SHA-001

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Manufacturer	:	LEEDARSON LIGHTING CO., LTD. Xingtai Industrial Park, Economic Development Zone of Changtai County, Zhangzhou City, Fujian Province, China

FCC ID: FHO-LED2208R1

Summary

The equipment complies with the requirements according to the following standard(s) or Specification: **47CFR Part 15 (2020):** Radio Frequency Devices (Subpart B)

ANSI C63.4 (2014): American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

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Revision History

Report No.	Version	Description	Issued Date
220602638SHA-001	Rev. 01	Initial issue of report	August 22,2022



Measurement result summary

TEST ITEM	FCC REFERENCE	TEST RESULT	NOTE
Conducted emission	15.107	Pass	
Radiation emission	15.109	Pass	

Notes: 1: NA =Not Applicable

2. Determination of the test conclusion is based on IEC Guide 115 in consideration of measurement uncertainty.

3: Additions, Deviations and Exclusions from Standards: None.

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1 GENERAL INFORMATION

1.1 Description of Equipment Under Test (EUT)

Product Name	:	Self-ballasted LED lamps
Type/Model	:	LED2208R1
Description of EUT	:	We tested it, and listed the worst data.
Rating	:	120V~, 60Hz, 4W, 87mA, E17
Brand name	:	IKEA
Category of EUT	:	Class B
EUT type	:	☐ Table top ☐ Floor standing
Sample received date	:	
Sample identification No.	:	0220629-12
Date of test	:	July 2-10, 2022

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1.2 Description of Test Facility

Name	:	Intertek Testing Services Shanghai
Address	:	Building 86, No. 1198 Qinzhou Road(North), Shanghai 200233, P.R. China
Telephone	:	86 21 61278200
Telefax	:	86 21 54262353
The test facility is recognized, certified, or accredited by these organizations		CNAS Accreditation Lab Registration No. CNAS L0139 FCC Accredited Lab Designation Number: CN0175 IC Registration Lab CAB identifier.: CN0051 VCCI Registration Lab Registration No.: R-14243, G-10845, C-14723, T-12252 A2LA Accreditation Lab Certificate Number: 3309.02

2.1 Standards or specification

47CFR Part 15 (2020): Radio Frequency Device: Subpart B

ANSI C63.4 (2014): Interim Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40GHz.

2.2 Mode of operation during the test

Within this test report, EUT was tested under all available operation modes and tested under its rating voltage and frequency. Other voltage and frequency is specified if used.

2.3 Test software list

Test Items	Software	Manufacturer	Version
Conducted emission	ESxS-K1	R&S	V2.1.0
Radiated emission	ES-K1	R&S	V1.71

2.4 Test peripherals list

ltem No.	Name	Band and Model	Description

2.5 Record of climatic conditions

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (Kpa)
Conducted emission	25	51	101
Radiated Emission	25	51	101

Notes: NA =Not Applicable

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<mark>Condu</mark>	Conducted Emission / Disturbance Power / Tri-loop Test / CDN method						
Used	Equipment	Manufacturer	Туре	Internal no.	Due date		
\boxtimes	Test Receiver	R&S	ESCS 30	EC 2107	2023-07-8		
\boxtimes	A.M.N.	R&S	ESH2-Z5	EC 3119	2022-11-9		
\boxtimes	Shielded room	Zhongyu	-	EC 2838	2023-01-11		
Radiat	ed Emission						
Used	Equipment	Manufacturer	Туре	Internal no.	Due date		
\boxtimes	Test Receiver	R&S	ESIB 26	EC 3045	2022-10-19		
\boxtimes	Bilog Antenna	TESEQ	CBL 6112B	EC 6411	2023-8-5		
\boxtimes	Semi-anechoic chamber	Albatross project	-	EC 3048	2023-08-21		
Additi	Additional instrument						
Used	Equipment	Manufacturer	Туре	Internal no.	Due date		
\bowtie	Therom- Hygrograph	ZJ1-2A	S.M.I.F.	EC 3783	2023-03-24		
\boxtimes	Therom- Hygrograph	ZJ1-2A	S.M.I.F.	EC 5198	2023-03-08		
\boxtimes	Pressure meter	YM3	Shanghai Mengde	EC 3320	2023-07-21		



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2.7 Measurement Uncertainty

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted emission at mains parts	9kHz ~ 150kHz	3.71 dB
Conducted emission at mains ports	150kHz ~ 30MHz	3.31 dB
Radiated Emissions up to 1 GHz	30MHz ~ 1GHz	5.04 dB
Radiated Emissions above 1 GHz	1GHz ~ 6GHz	4.97 dB
Radiated Emissions above 1 GHz	6GHz ~ 18GHz	5.29 dB

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Test result: Pass

3.1 Limits

3.1.1 Limits for conducted emission of class A device

Frequency range	Limits dB(μV)			
(MHz)	Quasi-peak	Average		
0.15 ~ 0.5	79	66		
0.5 ~ 30	73	60		
Note: If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the equipment under test shall be deemed to meet both limits and the				

measurement using the receiver with an average detector need not be carried out.

3.1.2 Limits for conducted emission of class B device

Frequency range	Limits dB(μV)				
(MHz)	Quasi-peak	Average			
0.15 ~ 0.5	66 ~ 56 *	56 ~ 46 *			
0.5 ~ 5	56	46			
5 ~ 30	60	50			
Note: 1. * Means the limit decreasing linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz 2. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the equipment under test shall be deemed to meet both limits and the measurement using the receiver with an average detector need not be carried out.					

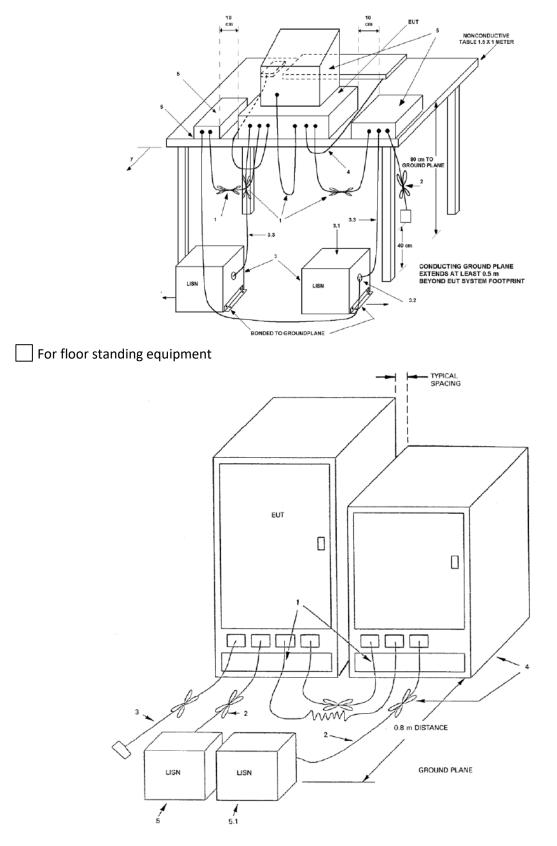
R

3.2 Test setup

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For table top equipment



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3.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were following clause 4 and clause 5 of ANSI 63.4.

Detailed test procedure was following clause 7.3 of ANSI 63.4.

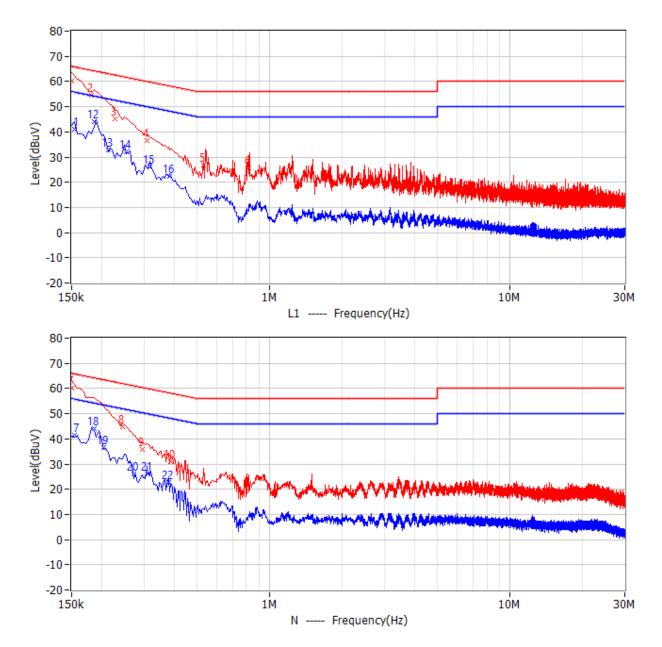
EUT arrangement and operation conditions were according to clause 6 and clause 7 of ANSI 63.4.

Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9 kHz.

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No.	Frequency	Limit dBuV	Level dBuV	Delta dB	Reading dBuV	Factor dB	Detector	Phase
1	150.000kHz	66.0	60.0	-6.0	53.8	6.2	QP	L1
2	181.500kHz	64.4	54.5	-10.0	48.3	6.2	QP	L1
3	226.500kHz	62.6	45.3	-17.2	39.1	6.2	QP	L1
4	307.500kHz	60.0	36.5	-23.6	30.3	6.2	QP	L1
5	532.500kHz	56.0	26.9	-29.1	20.7	6.2	QP	L1
6	816.000kHz	56.0	25.6	-30.4	19.4	6.2	QP	L1
7	150.000kHz	66.0	60.3	-5.7	54.1	6.2	QP	Ν
8	244.500kHz	61.9	44.9	-17.1	38.7	6.2	QP	Ν
9	294.000kHz	60.4	35.7	-24.8	29.5	6.2	QP	Ν
10	388.500kHz	58.1	30.8	-27.3	24.6	6.2	QP	Ν
11	154.500kHz	55.8	41.0	-14.7	34.8	6.2	CAV	L1

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No.	Frequency	Limit dBuV	Level dBuV	Delta dB	Reading dBuV	Factor dB	Detector	Phase
12	186.000kHz	54.2	44.0	-10.3	37.8	6.2	CAV	L1
13	213.000kHz	53.1	32.9	-20.2	26.7	6.2	CAV	L1
14	253.500kHz	51.6	31.9	-19.7	25.7	6.2	CAV	L1
15	316.500kHz	49.8	26.1	-23.7	19.9	6.2	CAV	L1
16	384.000kHz	48.2	22.2	-26.0	16.0	6.2	CAV	L1
17	154.500kHz	55.8	41.3	-14.4	35.0	6.3	CAV	Ν
18	186.000kHz	54.2	44.2	-10.0	38.0	6.2	CAV	Ν
19	204.000kHz	53.4	36.6	-16.9	30.3	6.3	CAV	Ν
20	271.500kHz	51.1	26.0	-25.1	19.8	6.2	CAV	Ν
21	312.000kHz	49.9	26.1	-23.8	19.9	6.2	CAV	Ν
22	379.500kHz	48.3	22.7	-25.6	16.5	6.2	CAV	Ν

Remark: 1. Correct Factor = LISN Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.

- 2. Corrected Reading = Original Receiver Reading + Correct Factor
- 3. Margin = Limit Corrected Reading
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB,

Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV.

Then Correct Factor = 10.00 + 2.00 = 12.00dB;

Corrected Reading = 10dBuV + 12.00dB = 22.00dBuV;

Margin = 66.00dBuV - 22.00dBuV = 44.00dB.



4 Radiated emission

Test result: PASS

4.1 Radiated emission limits

4.1.1 Limits for radiated emission of class A device

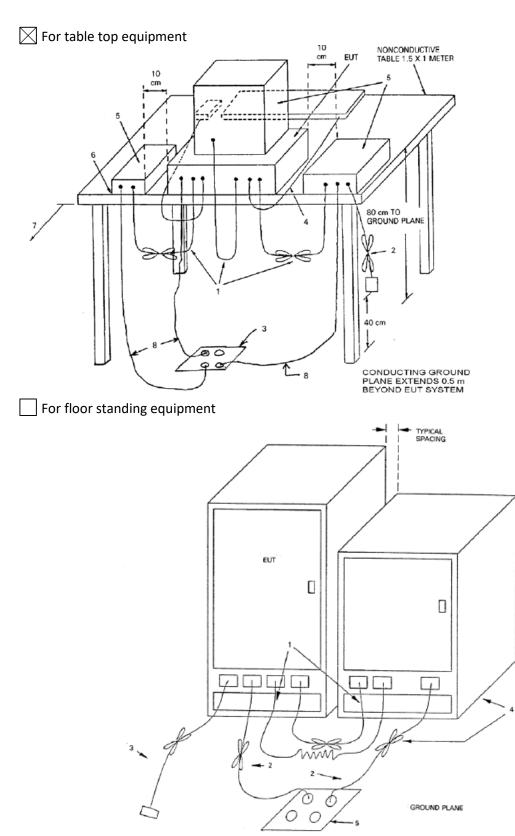
Frequency (MHz)	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 10m			
30 ~ 88	39			
88 ~ 216	43.5			
216 ~ 960	46.4			
Above 960	49.5			
Note: for the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10 decades.				

4.1.2 Limits for radiated emission of class B device

Frequency (MHz)	Permitted limit in dBμV/m (Quasi-peak) of Measurement Distance 3m			
30 ~ 88	40.0			
88 ~ 216	43.5			
216 ~ 960	46.0			
Above 960	54.0			
Note: for the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10 decades.				

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4.2 Block diagram and test set up





4.3 Test Setup and Test Procedure

The measurement was performed in a semi-anechoic chamber.

The distance from EUT to receiving antenna is 3 meter.

Measurement was performed according to clause 4 and clause 5 of ANSI 63.4.

Test procedure was according to clause 8.3 of ANSI 63.4.

EUT arrangement and operate condition were according to clause 6 and clause 8 of ANSI 63.4.

The bandwidth setting on R&S Test Receiver was 120 kHz.

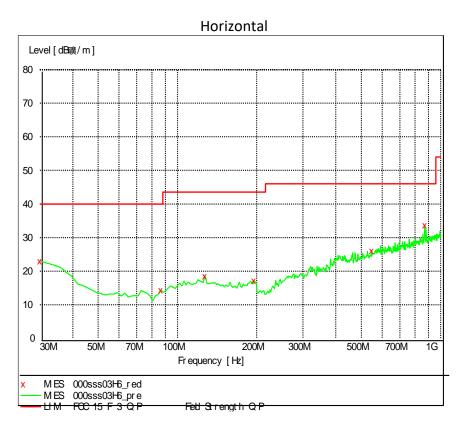
The required measurement frequency range was checked.

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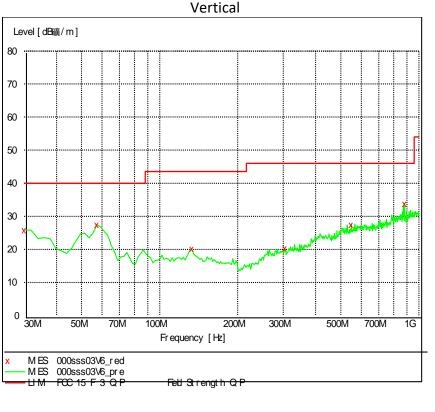
4.4 Test Protocol

Test Curve:



Frequency	<u>Level</u>	Transd	Limit	Margin
MHz	dBµV/m	dB dl	BµV/m	dB
30.000000	23.00	21.4	40.0	17.0
86.372745	14.30	10.2	40.0	25.7
127.194389	18.60	13.7	43.5	24.9
195.230461	17.20	11.2	43.5	26.3
547.074148	26.10	21.1	46.0	19.9
871.703407	33.70	24.1	46.0	12.3





Frequency	Level	Transd		Margin
MHz	dBµV/m	<u>dB_dBµV</u> /m		dB
30.000000	25.90	21.4	40.0	14.1
57.214429	27.50	8.6	40.0	12.5
133.026052	20.20	13.4	43.5	23.3
304.088176	20.30	15.9	46.0	25.7
549.018036	27.50	21.1	46.0	18.5
881.422846	33.70	24.2	46.0	12.3

Remark: 1.Correct Factor = Antenna Factor + Cable Loss (+ Amplifier, for higher than 1GHz)

2. Corrected Reading = Original Receiver Reading + Correct Factor

3. Margin = Limit - Corrected Reading

4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,

Gain of Preamplifier = 32.00dB, Original Receiver Reading = 10.00dBuV, limit = 40.00dBuV/m. Then Correct Factor = 30.20 + 2.00 - 32.00 = 0.20dB/m; Corrected Reading = 10dBuV + 0.20dB/m = 10.20dBuV/m; Margin = 40.00dBuV/m - 10.20dBuV/m = 29.80dB.

END of the report